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Composition analysis of Ta₃N₅/W₁₈O₄₉ nanocomposite through XPS

Daniel R. Jones, Michael E. A. Warwick, James D. McGettrick, and Charles W. Dunnill

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Composition analysis of Ta₃N₅/W₁₈O₄₉ nanocomposite through XPS

Daniel R. Jones,¹ Michael E. A. Warwick,¹ James D. McGettrick,² and Charles W. Dunnill^{1,a)} ¹Energy Safety Research Institute (ESRI), Swansea University Bay Campus, Swansea SA1 8EN, United Kingdom ²SPECIFIC Swansea University Bay Campus, Swansea SA1 8EN, United Kingdom

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A characterization of a nanocomposite material consisting of Ta_3N_5 nanoparticles and $W_{18}O_{49}$ nanowires is presented. The material is of interest for photocatalytic applications, with a focus on pollution reduction through the photodegradation of dye waste; under white light illumination, the combination of Ta_3N_5 and $W_{18}O_{49}$ yielded an enhanced rate of dye degradation relative to Ta_3N_5 particles alone. The facile method of synthesis is thought to be a promising route for both upscale and commercial utilization of the material. X-ray photoelectron spectroscopy revealed a core–shell composite structure with $W_{18}O_{49}$ present as an overlayer on Ta_3N_5 ; the analyzed spectra for the C 1*s*, O 1*s*, Ta 4*f*, N 1*s*, W 4*f*, and Na 1*s* regions are reported. It should be noted that due to differential charging of the underlying Ta_3N_5 component relative to the $W_{18}O_{49}$ shell, an additional uncompensated voltage shift may exist in the Ta 4*f* and N 1*s* spectra. *Published by the AVS*. https://doi.org/10.1116/1.5047860

Keywords: Ta_3N_5 , $W_{18}O_{49}$, photocatalysis, dye degradation, composite, nanowires, x-ray photoelectron spectroscopy, XPS

INTRODUCTION -

Many synthetic dyes are toxic to both human (Ref. 1) and marine life (Ref. 2) and inhibit aquatic photosynthesis through light absorption (Ref. 3), leading to concerns for global oxygen production. Many synthetic dyes are, by design, chemically stable and are therefore difficult to degrade via common biological treatment (Refs. 4 and 5), while alternative techniques can lead to the production of unwanted by-products which are also harmful (Refs. 6-9). One promising, low-energy solution for the remediation of dye-polluted water is the use of photocatalysts for oxidation of the dyes. Much work has focused on the use of TiO_2 nanopowders for this purpose (Refs. 10–17); however, TiO_2 has a wide bandgap (3.2 eV) and can therefore utilize only the ultraviolet portion of the solar spectrum, which accounts for a small percentage of solar radiation that reaches the earth. With this in mind, it is preferable to employ a material with a narrower bandgap so that dye oxidation may be instigated by visible light. With its low bandgap of 2.1 eV (Ref. 18), Ta₃N₅ has been shown to work well as a visible light photocatalyst for the degradation of organic dyes (Refs. 19-21), although our recent study demonstrated how the catalytic performance of this material may be enhanced through a strategic combination with tungsten(IV) suboxide nanowires in the form of a composite (Ref. 22). Within this investigation, a solvothermal approach was employed to grow W18O49 nanofibers on Ta₃N₅ nanoparticles inside a polytetrafluoroethylenelined stainless steel acid digestion bomb, and it was found that the combination of these materials resulted in improved charge carrier separation due to electron-hole transfer at the interface of the two components; the increase in charge separation afforded longer charge carrier lifetimes, resulting in a marked increase in the photocatalytic activity of the material. To the



Accession #: 01477

Technique: XPS

Host Material: Ta₃N₅/W₁₈O₄₉ nanocomposite

Instrument: Kratos Axis Supra

Major Elements in Spectra: W, O

Minor Elements in Spectra: Ta, N, C

Published Spectra: 6

Spectra in Electronic Record: 6

Spectral Category: Comparison

best of the authors' knowledge, this system has not before been synthesized for the purpose of water remediation.

SPECIMEN DESCRIPTION (ACCESSION #01477) ----

Host Material: Ta₃N₅/W₁₈O₄₉ nanocomposite

CAS Registry #: Unknown

- Host Material Characteristics: Inhomogeneous; powder; polycrystalline; semiconductor; composite
- **Chemical Name:** Tantalum(V) nitride/tungsten(VI) suboxide
- **Source:** Solvothermally grown W₁₈O₄₉ on Ta₃N₅ from ammonolyzed TaCl₅

Host Composition: Ta₃N₅/W₁₈O₄₉

Form: Polycrystalline composite

Structure: Orthorhombic Ta₃N₅/monoclinic W₁₈O₄₉

- **History and Significance:** Ta_3N_5 nanoparticles were prepared through ammonolysis of $TaCl_5$ powder in a 7:3 molar ratio of KCl and NaCl at 800 °C for 10 h. Nanowires of $W_{18}O_{49}$ were subsequently grown solvothermally on the surface of the Ta_3N_5 nanoparticles by annealing a suspension of the nanoparticles in a solution of WCl₆ in a 4:1 volumetric mixture of ethanol and ethylene glycol at 180 °C for 24 h, followed by centrifugation of the product in ethanol and deionized water.
- As Received Condition: The as-synthesized composite had the form of a brown powder.

Analyzed Region: Same as the host material

Ex Situ Preparation/Mounting: The composite powder was loaded into a 5 mm pellet press and pelletized using a force of 2 tons. The pellet was retrieved from the press and mounted on an adhesive carbon tab for analysis.

In Situ Preparation: None

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Charge Control: Electronic charge neutralization using magnetic immersion lens. Filament current = 0.4 A, charge balance = 3.3 V, filament bias = 1.0 V.

Temp. During Analysis: 300 K

Pressure During Analysis: 4×10^{-6} Pa

Preanalysis Beam Exposure: 0 s

INSTRUMENT DESCRIPTION -

Manufacturer and Model: Kratos Axis Supra
Analyzer Type: Spherical sector
Detector: Multichannel resistive plate
Number of Detector Elements: 3 MCP, 128 channel DLD

INSTRUMENT PARAMETERS COMMON TO ALL SPECTRA

Spectrometer

Analyzer Mode: Constant pass energy Throughput ($T = E^N$): N = 0Excitation Source Window: Not specified Excitation Source: Al K_{\alpha} monochromatic Source Energy: 1486.6 eV Source Strength: 225 W Source Beam Size: 700 \mum × 300 \mum Signal Mode: Multichannel direct

Geometry

Incident Angle: 54.7° Source-to-Analyzer Angle: 54.7° Emission Angle: 0° Specimen Azimuthal Angle: N/A Acceptance Angle from Analyzer Axis: 0° Analyzer Angular Acceptance Width: 30° × 30°

Ion Gun

Manufacturer and Model: Kratos GCIS Minibeam 6 Energy: 10 keV

Current: 23 nA

Current Measurement Method: Biased stage

Sputtering Species: Argon 1000+ ion clusters

Spot Size (unrastered): 200 µm

Raster Size: $2000 \,\mu\text{m} \times 2000 \,\mu\text{m}$

Incident Angle: 40°

Polar Angle: 0°

Azimuthal Angle: 0°

Comment: Sputtering was carried out on the reference samples only.

DATA ANALYSIS METHOD -

Energy Scale Correction: The binding energy scale was referenced to C 1s = 284.8 eV.

Recommended Energy Scale Shift: 3.213 eV

- **Peak Shape and Background Method:** Peak shape: Gaussian–Lorentzian product formula GL(30). Background: The Shirley background was used.
- **Quantitation Method:** Quantification was achieved through peak deconvolution using CASAXPS version 2.3.15. Relative sensitivity factors were supplied by Kratos Analytical.

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	SPECTRAL FEATURES TABLE						
Spectrum ID #	Element/ Transition	Peak Energy (eV)	Peak Width FWHM (eV)	Peak Area (eV × counts/s)	Sensitivity Factor	Concentration (at. %)	Peak Assignment
01477-02	W 4f _{7/2}	35.9	1.14	33 987	3.523	12.84	WO ₃
01477-02	W 4f _{5/2}	38.1	1.14	25 490	3.523		WO ₃
01477-02	W 4f _{7/2}	34.6	0.93	4 298	3.523		W_2O_5
01477-02	W 4f _{5/2}	36.7	0.93	3 2 2 3	3.523		W_2O_5
01477-03	O 1s	530.6	1.21	41 006	0.780	40.20	WO_3/W_2O_5
01477-03	O 1s	531.6	1.21	8 556	0.780		Surface –OH
01477-03	O 1s	532.6	1.21	5319	0.780		Adventitious organics
01477-03	O 1s	533.6	1.21	2 904	0.780		Adventitious organics
01477-04	C 1s	284.8	1.35	18 539	0.278	45.52	Adventitious C–C/C–H
01477-04	C 1s	286.4	1.35	2 820	0.278		Adventitious C–O/C=O
01477-05	Ta 4 <i>f</i>	25.4	0.86	1 731	3.082	0.62	Ta_3N_5
01477-06	N 1s	396.7	0.93	351	0.477	0.81	Ta_3N_5

ANALYZER CALIBRATION TABLE							
Spectrum ID #	Element/ Transition	Peak Energy (eV)	Peak Width FWHM (eV)	Peak Area (eV × counts/s)	Sensitivity Factor	Concentration (at. %)	Peak Assignment
08	Ag 3 <i>d</i> _{5/2}	368.4	0.51	71 961	5.987		Ag
10	Au 4f _{7/2}	84.0	0.60	314 838	6.250		Au
12	Cu 2p _{3/2}	933.0	0.80	401 503	5.321		Cu

Composition analysis of $Ta_3N_5/W_{18}O_{49}$ nanocomposite 024002-3

GUIDE TO FIGURES					
Spectrum (Accession) #	Spectral Region	Voltage Shift ^a	Multiplier	Baseline	Comment # ^b
01477-01	Survey	3.213	1	0	1
01477-02	W 4f	3.213	1	0	1
01477-02	W 4f	3.213	1	0	1
01477-03	O 1s	3.213	1	0	1
01477-03	O 1s	3.213	1	0	1
01477-04	C 1s	3.213	1	0	1
01477-04	C 1s	3.213	1	0	1
01477-05	Ta 4 <i>f</i>	3.213	1	0	1
01477-06	N 1 <i>s</i>	3.213	1	0	1
07	Survey	0	1	0	2
08	Ag 3 <i>d</i> _{5/2}	0	1	0	2
09	Survey	0	1	0	3
10	Au 4f _{7/2}	0	1	0	3
11	Survey	0	1	0	4
12	Cu 2p _{3/2}	0	1	0	4

^aVoltage shift of the published figure relative to the as-measured spectrum; the energy correction accounts for the effects of sample charging. b 1. Ta₃N₅/W₁₈O₄₉ nanocomposite. 2. Ag calibration. 3. Au calibration. 4. Cu calibration.



Accession #	01477-01
Host Material:	Ta ₃ N ₅ /W ₁₈ O ₄₉ nanocomposite
Technique:	XPS
Spectral Region:	Survey
Instrument:	Kratos Axis Supra
Excitation Source:	Al K_{α} monochromatic
Source Energy:	1486.6 eV
Source Strength:	225 W
Source Size:	0.7 mm × 0.3 mm
Analyzer Type:	Spherical sector analyzer
Incident Angle:	54.7°
Emission Angle:	0°
Analyzer Pass Energy:	160 eV
Analyzer Resolution:	1 eV
Total Signal Accumulation Time:	120 s
Total Elapsed Time:	Not specified
Number of Scans:	1
Effective Detector Width:	16 eV

■ Host Material: Ta ₃ N ₅ / W ₁₈ O ₄₉ nanocomposite ■ Technique: XPS ■ Spectral Region: O 1s Instrument: Kratos Axis Supra Excitation Source: AI K _α monochromatic Source Energy: 1486.6 eV Source Strength: 225 W Source Size: 0.7 mm × 0.3 mm Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Accession #: 01477-03
 Technique: XPS Spectral Region: O 1s Instrument: Kratos Axis Supra Excitation Source: AI K_α monochromatic Source Energy: 1486.6 eV Source Strength: 225 W Source Size: 0.7 mm × 0.3 mm Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV 	 Host Material: Ta₃N₅/ W₁₈O₄₉ nanocomposite
 Spectral Region: O 1s Instrument: Kratos Axis Supra Excitation Source: AI K_α monochromatic Source Energy: 1486.6 eV Source Strength: 225 W Source Size: 0.7 mm × 0.3 mm Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV 	Technique: XPS
Instrument: Kratos Axis Supra Excitation Source: Al K _{α} monochromatic Source Energy: 1486.6 eV Source Strength: 225 W Source Size: 0.7 mm × 0.3 mm Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	■ Spectral Region: O 1s
Excitation Source: Al K_{α} monochromatic Source Energy: 1486.6 eV Source Strength: 225 W Source Size: 0.7 mm × 0.3 mm Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Instrument: Kratos Axis Supra
Source Energy: 1486.6 eV Source Strength: 225 W Source Size: 0.7 mm × 0.3 mm Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Excitation Source: Al K_{α} monochromatic
Source Strength: 225 W Source Size: 0.7 mm × 0.3 mm Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Source Energy: 1486.6 eV
Source Size: 0.7 mm × 0.3 mm Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Source Strength: 225 W
Analyzer Type: Spherical sector Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Source Size: 0.7 mm × 0.3 mm
Incident Angle: 54.7° Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Analyzer Type: Spherical sector
Emission Angle: 0° Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Incident Angle: 54.7°
Analyzer Pass Energy: 20 eV Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Emission Angle: 0°
Analyzer Resolution: 0.1 eV Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Analyzer Pass Energy: 20 eV
Total Signal Accumulation Time: 19 s Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Analyzer Resolution: 0.1 eV
Total Elapsed Time: Not specified Number of Scans: 1 Effective Detector Width: 2 eV	Total Signal Accumulation Time: 19 s
Number of Scans: 1 Effective Detector Width: 2 eV	Total Elapsed Time: Not specified
Effective Detector Width: 2 eV	Number of Scans: 1
	Effective Detector Width: 2 eV

 Accession #: 01477-03 Host Material: Ta₃N₅/ W₁₈O₄₉ nanocomposite Technique: XPS
Spectral Region: 0 1s
Instrument: Kratos Axis Supra
Excitation Source: Al K_{α} monochromatic
Source Energy: 1486.6 eV
Source Strength: 225 W
Source Size: 0.7 mm × 0.3 mm
Analyzer Type: Spherical sector
Incident Angle: 54.7°
Emission Angle: 0°
Analyzer Pass Energy: 20 eV
Analyzer Resolution: 0.1 eV
Total Signal Accumulation Time: 19 s
Total Elapsed Time: Not specified
Number of Scans: 1
Effective Detector Width: 2 eV

 Accession #: 01477-04 Host Material: Ta₃N₅/ W₁₈O₄₉ nanocomposite Technique: XPS Spectral Region: C 1s
Instrument: Kratos Axis Supra
Excitation Source: Al K_{α} monochromatic
Source Energy: 1486.6 eV
Source Strength: 225 W
Source Size: 0.7 mm × 0.3 mm
Analyzer Type: Spherical sector
Incident Angle: 54.7°
Emission Angle: 0°
Analyzer Pass Energy: 20 eV
Analyzer Resolution: 0.1 eV
Total Signal Accumulation Time: 29.5 s
Total Elapsed Time: Not specified
Number of Scans: 2
Effective Detector Width: 2 eV

 Accession #: 01477-05 Host Material: Ta₃N₅/ W₁₈O₄₉ nanocomposite Technique: XPS Spectral Region: Ta 4f
Instrument: Kratos Axis Supra
Excitation Source: Al K_{α} monochromatic
Source Energy: 1486.6 eV
Source Strength: 225 W
Source Size: 0.7 mm × 0.3 mm
Analyzer Type: Spherical sector
Incident Angle: 54.7°
Emission Angle: 0°
Analyzer Pass Energy: 20 eV
Analyzer Resolution: 0.1 eV
Total Signal Accumulation Time: 17.5 s
Total Elapsed Time: Not specified
Number of Scans: 1
Effective Detector Width: 2 eV

